

Notice of References Cited	Application/Control No. 10/588,125		Applicant(s)/Patent Under Reexamination OHGARU ET AL.	
	Examiner Shean C. Wu		Art Unit 1795	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,166,339	01-2007	Mori et al.	428/1.33
	B	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	U	English translation by computer for JP 2004-50516, http://www4.ipdl.inpit.go.jp/Tokujitu/PAJdetail.ipdl?N0000=60&N0120=01&N2001=2&N3001=2004-050516 , 2004
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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